

<b>Notice of References Cited</b>	Application/Control No. 10/692,082	Applicant(s)/Patent Under Reexamination FICKLE ET AL.	
	Examiner Nnenna N. Ofurum	Art Unit 2623	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,621,870	09-2003	Gordon et al.	375/240.28
*	B	US-5,767,895	06-1998	Yashiro et al.	725/106
*	C	US-6,529,706	03-2003	Mitchell, James P.	455/12.1
*	D	US-7,010,801	03-2006	Jerding et al.	725/95
*	E	US-6,151,321	11-2000	Benson et al.	370/395.42
*	F	US-2004/0181801	09-2004	Hagen et al.	725/032
*	G	US-7,185,352	02-2007	Hallford et al.	725/28
*	H	US-2003/0120608	06-2003	Pereyra, Jorge	705/64
*	I	US-6,477,707	11-2002	King et al.	725/97
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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